

### SEMITRANS® 3

### Fast IGBT4 Modules

### SKM600GAL12T4

### Features\*

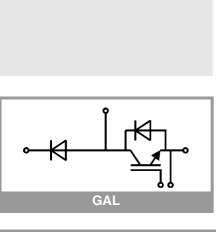
- IGBT4 = 4th generation fast trench IGBT (Infineon)
- CAL4 = Soft switching 4th generation CAL-diode
- Insulated copper baseplate using DBC technology (Direct Bonded Copper)
- Increased power cycling capability
- With integrated gate resistor
- For higher switching frequencies up to 20kHz
- UL recognized, file no. E63532

### **Typical Applications**

- Electronic welders at fsw up to 20 kHz
- DC/DC converter
- · Brake chopper
- · Switched reluctance motor

### **Remarks**

- · Case temperature limited to  $T_c = 125$ °C max.
- Recommended T<sub>op</sub> = -40 ... +150°C
- Product reliability results valid for  $T_i = 150$ °C



| Absolute            | Maximum Ratin   | gs                      |         |      |  |
|---------------------|---|-------------------------|---------|------|--|
| Symbol              | Conditions  |                         | Values  | Unit |  |
| IGBT                | •   |                         |         |      |  |
| $V_{CES}$           | T <sub>j</sub> = 25 °C  |                         | 1200    | V    |  |
| Ic                  | T <sub>i</sub> = 175 °C   | T <sub>c</sub> = 25 °C  | 860     | Α    |  |
|                     | 1, - 175 0  | T <sub>c</sub> = 80 °C  | 702     | Α    |  |
| I <sub>Cnom</sub>   |   |                         | 600     | Α    |  |
| I <sub>CRM</sub>    |   |                         | 1800    | Α    |  |
| V <sub>GES</sub>    |   |                         | -20 20  | V    |  |
| t <sub>psc</sub>    | $V_{CC} = 800 \text{ V}$<br>$V_{GE} \le 15 \text{ V}$<br>$V_{CES} \le 1200 \text{ V}$ | T <sub>j</sub> = 150 °C | 10      | μѕ   |  |
| Tj                  |   | •                       | -40 175 | °C   |  |
| Inverse d           | liode   |                         |         | •    |  |
| V <sub>RRM</sub>    | T <sub>j</sub> = 25 °C  |                         | 1200    | V    |  |
| I <sub>F</sub>      | T <sub>j</sub> = 175 °C   | T <sub>c</sub> = 25 °C  | 623     | Α    |  |
|                     |   | T <sub>c</sub> = 80 °C  | 466     | Α    |  |
| I <sub>Fnom</sub>   |   | <b>'</b>                | 500     | Α    |  |
| I <sub>FRM</sub>    |   |                         | 1200    | Α    |  |
| I <sub>FSM</sub>    | t <sub>p</sub> = 10 ms, sin 180°, T <sub>j</sub> = 25 °C                              |                         | 2736    |      |  |
| Tj                  | ,   |                         | -40 175 | °C   |  |
| Freewhee            | eling diode   |                         |         |      |  |
| V <sub>RRM</sub>    | T <sub>j</sub> = 25 °C  |                         | 1200    | V    |  |
| l <sub>F</sub>      | T <sub>j</sub> = 175 °C   | T <sub>c</sub> = 25 °C  | 707     | Α    |  |
|                     |   | T <sub>c</sub> = 80 °C  | 529     | Α    |  |
| I <sub>Fnom</sub>   |   |                         | 600     | Α    |  |
| I <sub>FRM</sub>    |   |                         | 1200    | Α    |  |
| I <sub>FSM</sub>    | t <sub>p</sub> = 10 ms, sin 180°, T <sub>i</sub> = 25 °C                              |                         | 3240    | А    |  |
| T <sub>j</sub>      |   |                         | -40 175 | °C   |  |
| Module              | •   |                         | 1       | L    |  |
| I <sub>t(RMS)</sub> |   |                         | 500     | Α    |  |
| T <sub>stg</sub>    | module without  | ГІМ                     | -40 125 | °C   |  |
| V <sub>isol</sub>   | AC sinus 50 Hz,   | t = 1 min               | 4000    | V    |  |

| Characteristics      |   |                         |      |      |      |    |  |
|----------------------|---|-------------------------|------|------|------|----|--|
| Symbol               | Conditions  | min.                    | typ. | max. | Unit |    |  |
| IGBT                 |   |                         |      |      |      |    |  |
| V <sub>CE(sat)</sub> | $I_{\rm C} = 600  {\rm A}$  | T <sub>j</sub> = 25 °C  |      | 1.80 | 2.05 | ٧  |  |
|                      | V <sub>GE</sub> = 15 V<br>chiplevel                                     | T <sub>j</sub> = 150 °C |      | 2.20 | 2.42 | V  |  |
| V <sub>CE0</sub>     | chiplevel   | T <sub>j</sub> = 25 °C  |      | 0.80 | 0.90 | V  |  |
|                      |   | T <sub>j</sub> = 150 °C |      | 0.70 | 0.80 | V  |  |
| r <sub>CE</sub>      | V <sub>GE</sub> = 15 V  | T <sub>j</sub> = 25 °C  |      | 1.67 | 1.92 | mΩ |  |
|                      | chiplevel   | T <sub>j</sub> = 150 °C |      | 2.5  | 2.7  | mΩ |  |
| $V_{GE(th)}$         | V <sub>GE</sub> =V <sub>CE</sub> , I <sub>C</sub> = 24 mA               |                         | 5    | 5.8  | 6.5  | V  |  |
| I <sub>CES</sub>     | V <sub>GE</sub> = 0 V, V <sub>CE</sub> = 1200 V, T <sub>j</sub> = 25 °C |                         |      |      | 5    | mA |  |
| C <sub>ies</sub>     | V <sub>CE</sub> = 25 V<br>V <sub>GE</sub> = 0 V                         | f = 1 MHz               |      | 37.2 |      | nF |  |
| Coes                 |   | f = 1 MHz               |      | 2.32 |      | nF |  |
| C <sub>res</sub>     |   | f = 1 MHz               |      | 2.04 |      | nF |  |
| $Q_{G}$              | V <sub>GE</sub> = - 8 V+ 15 V   |                         |      | 3400 |      | nC |  |
| R <sub>Gint</sub>    | T <sub>j</sub> = 25 °C  |                         |      | 1.3  |      | Ω  |  |



### Fast IGBT4 Modules

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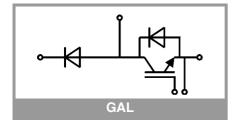
### **Typical Applications**

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### **Remarks**

- · Case temperature limited to  $T_c = 125$ °C max.
- Recommended T<sub>op</sub> = -40 ... +150°C
- Product reliability results valid for  $T_i = 150$ °C

| Characte                         | ristics   |                         |      |       |       |      |
|----------------------------------|---|-------------------------|------|-------|-------|------|
| Symbol                           | Conditions  |                         | min. | typ.  | max.  | Unit |
| IGBT                             |   |                         |      |       |       |      |
| t <sub>d(on)</sub>               | V <sub>CC</sub> = 600 V   | T <sub>i</sub> = 150 °C |      | 178   |       | ns   |
| t <sub>r</sub>                   | $I_{\rm C} = 600  {\rm A}$  | T <sub>i</sub> = 150 °C |      | 68    |       | ns   |
| E <sub>on</sub>                  | $V_{GE} = +15/-15 \text{ V}$<br>$R_{G \text{ on}} = 1.6 \Omega$   | T <sub>i</sub> = 150 °C |      | 33    |       | mJ   |
| t <sub>d(off)</sub>              | $R_{G \text{ off}} = 1.0 \Omega$  | T <sub>i</sub> = 150 °C |      | 523   |       | ns   |
| t <sub>f</sub>                   | $di/dt_{on} = 8900 \text{ A/}\mu\text{s}$   | T <sub>i</sub> = 150 °C |      | 116   |       | ns   |
| E <sub>off</sub>                 | $di/dt_{off} = 4300 \text{ A/}\mu \text{s}$<br>$dv/dt = 3550 \text{ V/}\mu \text{s}$<br>$L_s = 24 \text{ nH}$ | T <sub>j</sub> = 150 °C |      | 70    |       | mJ   |
| R <sub>th(j-c)</sub>             | per IGBT  |                         |      |       | 0.049 | K/W  |
| R <sub>th(c-s)</sub>             | per IGBT (λ <sub>grease</sub> =0.   | .81 W/(m*K))            |      | 0.032 |       | K/W  |
| R <sub>th(c-s)</sub>             | per IGBT, pre-applied phase change material   |                         |      | 0.016 |       | K/W  |
| Inverse d                        | iode  |                         |      |       |       | ı    |
| V <sub>E</sub> = V <sub>EC</sub> | I <sub>F</sub> = 600 A  | T <sub>i</sub> = 25 °C  |      | 2.28  | 2.63  | V    |
|                                  | V <sub>GE</sub> = 0 V<br>chiplevel  | T <sub>j</sub> = 150 °C |      | 2.28  | 2.61  | V    |
| $V_{F0}$                         | chiplevel   | T <sub>i</sub> = 25 °C  |      | 1.30  | 1.50  | V    |
| -10                              |   | T <sub>i</sub> = 150 °C |      | 0.90  | 1.10  | V    |
| r <sub>F</sub>                   | chiplevel   | T <sub>i</sub> = 25 °C  |      | 1.64  | 1.88  | mΩ   |
|                                  |   | T <sub>j</sub> = 150 °C |      | 2.3   | 2.5   | mΩ   |
| I <sub>RRM</sub>                 | I <sub>F</sub> = 600 A  | T <sub>j</sub> = 150 °C |      | 566   |       | Α    |
| Q <sub>rr</sub>                  | di/dt <sub>off</sub> = 8700 A/μs  | T <sub>j</sub> = 150 °C |      | 99    |       | μС   |
| E <sub>rr</sub>                  | $V_{GE} = -15 \text{ V}$<br>$V_{CC} = 600 \text{ V}$  | T <sub>j</sub> = 150 °C |      | 40    |       | mJ   |
| R <sub>th(j-c)</sub>             | per diode   |                         |      |       | 0.095 | K/W  |
| R <sub>th(c-s)</sub>             | per diode (λ <sub>grease</sub> =0.81 W/(m*K))   |                         |      | 0.039 |       | K/W  |
| $R_{\text{th(c-s)}}$             | per diode, pre-applied phase change<br>material   |                         |      | 0.028 |       | K/W  |
| Freewhee                         | eling diode   |                         |      |       |       |      |
| $V_F = V_{EC}$                   | I <sub>F</sub> = 600 A  | T <sub>j</sub> = 25 °C  |      | 2.14  | 2.46  | V    |
|                                  | V <sub>GE</sub> = 0 V<br>chiplevel  | T <sub>j</sub> = 150 °C |      | 2.07  | 2.38  | V    |
| $V_{F0}$                         | ahinlayal   | T <sub>j</sub> = 25 °C  |      | 1.30  | 1.50  | V    |
|                                  | chiplevel   | T <sub>j</sub> = 150 °C |      | 0.90  | 1.10  | V    |
| r <sub>F</sub>                   | chiplevel   | T <sub>j</sub> = 25 °C  |      | 1.40  | 1.60  | mΩ   |
|                                  | Chipievei   | T <sub>j</sub> = 150 °C |      | 1.95  | 2.1   | mΩ   |
| I <sub>RRM</sub>                 | $I_F = 600 \text{ A}$   | T <sub>j</sub> = 150 °C |      | 600   |       | Α    |
| Q <sub>rr</sub>                  | $di/dt_{off} = 9000 \text{ A/}\mu\text{s}$<br>$V_{GE} = \pm 15 \text{ V}$                                     | T <sub>j</sub> = 150 °C |      | 90    |       | μC   |
| E <sub>rr</sub>                  | $V_{CC} = 600 \text{ V}$  | T <sub>j</sub> = 150 °C |      | 39    |       | mJ   |
| R <sub>th(j-c)</sub>             | per diode   | 1                       |      |       | 0.086 | K/W  |
| R <sub>th(c-s)</sub>             | per diode (λ <sub>grease</sub> =0   | .81 W/(m*K))            |      | 0.038 |       | K/W  |
| R <sub>th(c-s)</sub>             | per diode, pre-appl<br>material   | ied phase change        |      | 0.024 |       | K/W  |





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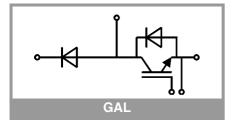
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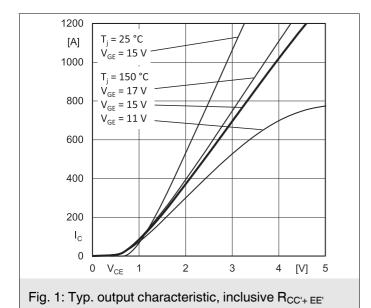
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| Characte              | eristics  |                         |        |       |      |      |
|-----------------------|---|-------------------------|--------|-------|------|------|
| Symbol                | Conditions  |                         | min.   | typ.  | max. | Unit |
| Module                |   |                         | •      |       |      | •    |
| L <sub>CE</sub>       |   |                         |        | 15    |      | nΗ   |
| R <sub>CC'+EE'</sub>  | measured per<br>switch  | T <sub>C</sub> = 25 °C  |        | 0.55  |      | mΩ   |
|                       |   | T <sub>C</sub> = 125 °C |        | 0.85  |      | mΩ   |
| R <sub>th(c-s)1</sub> | calculated without thermal coupling   |                         | 0.0172 |       |      | K/W  |
| R <sub>th(c-s)2</sub> | including thermal coupling, Ts underneath module (λ <sub>grease</sub> =0.81 W/(m*K))      |                         |        | 0.020 |      | K/W  |
| R <sub>th(c-s)2</sub> | including thermal coupling,<br>Ts underneath module, pre-applied<br>phase change material |                         |        | 0.011 |      | K/W  |
| Ms                    | to heat sink M6   |                         | 3      |       | 5    | Nm   |
| M <sub>t</sub>        |   | to terminals M6         | 2.5    |       | 5    | Nm   |
|                       |   |                         |        |       |      | Nm   |
| w                     |   | •                       |        |       | 325  | g    |





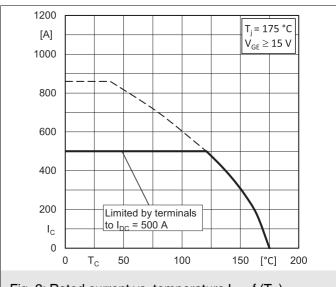


Fig. 2: Rated current vs. temperature  $I_C = f(T_C)$ 

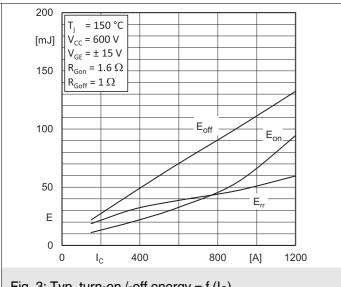


Fig. 3: Typ. turn-on /-off energy =  $f(I_C)$ 

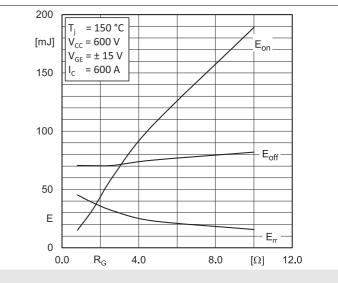


Fig. 4: Typ. turn-on /-off energy =  $f(R_G)$ 

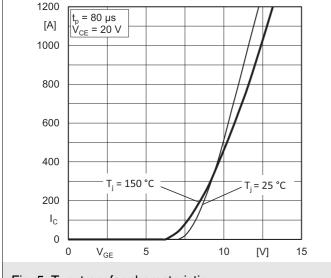


Fig. 5: Typ. transfer characteristic

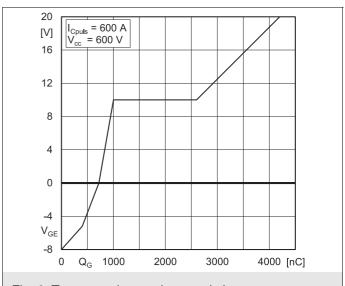
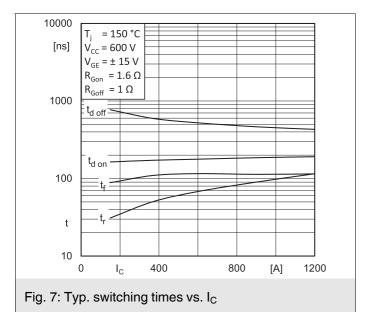
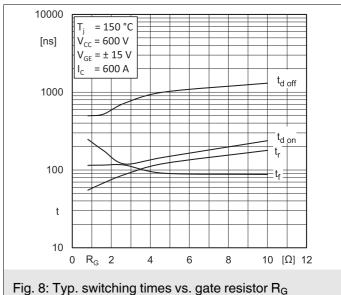
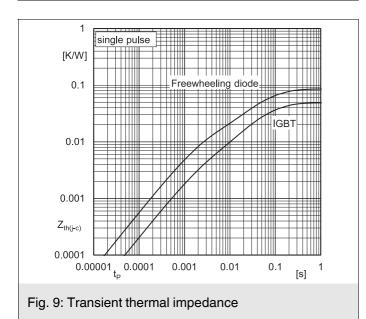
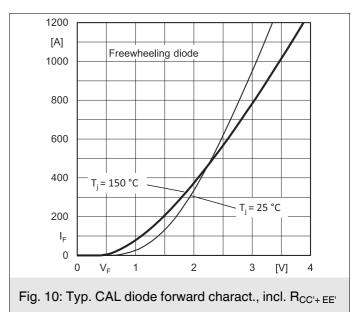


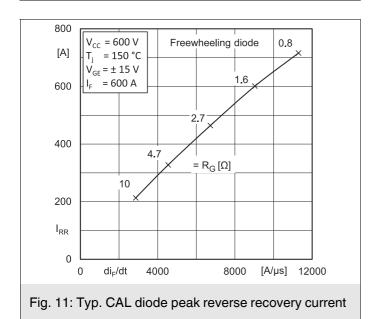
Fig. 6: Typ. gate charge characteristic











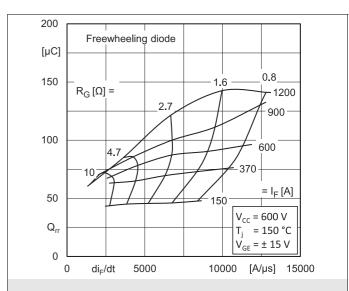
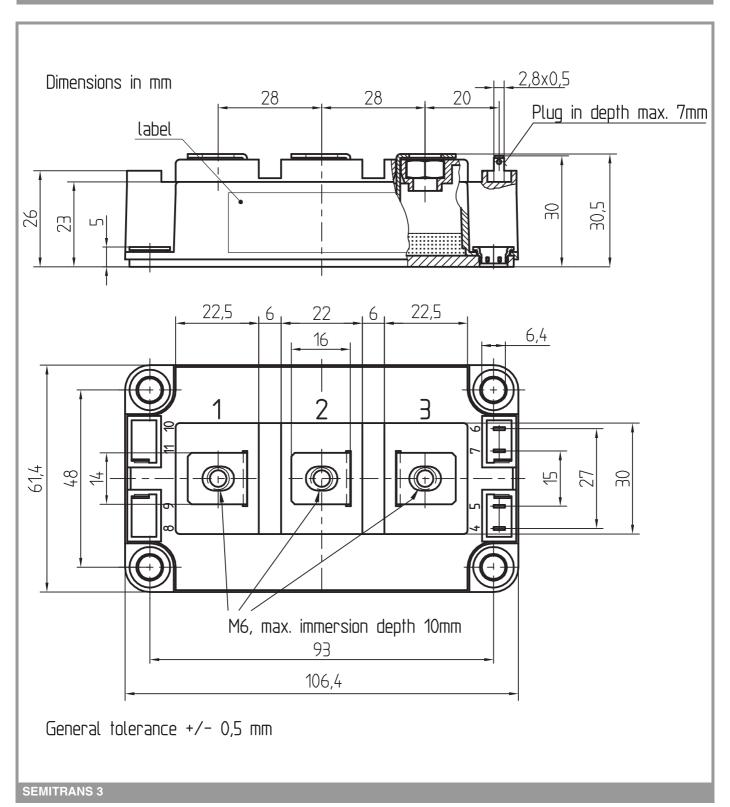
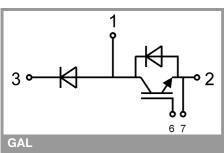


Fig. 12: Typ. CAL diode peak reverse recovery charge





This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, chapter IX.

#### \*IMPORTANT INFORMATION AND WARNINGS

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